Search Notes

Application/Control No.	No. Applicant(s)/Patent under Reexamination	
10/542,210	SCHMID ET AL.	
Examiner	Art Unit	
HUNG T. NGUYEN	2612	

	SEARCHED				
Class	Subclass	Date	Examiner		
340	438	3/14/2007	HN		
340	439				
340	635				
340	441				
340	425.5				
235	375				
235	376				
235	380				
235	383				
701	46				
710	11				
710	14				
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INT	INTERFERENCE SEARCHED			
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SEAR (INCLUDING SI	CH NOTES EARCH STRATEGY	·)
	DATE	EXMR
PLUS SEARCH	3/14/2007	HN
EAST	3/14/2007	HN
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